TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

2SK1739A

RF POWER MOS FET for UHF TV BROADCAST TRANSMITTER

- **Output** Power $: Po \ge 90 W$ (Min.)
- Drain Efficiency
- Frequency
- $: \eta_{\rm D} = 50\%$ (Typ.)
- : f = 770 MHz
- Push-Pull Structure Package

MAXIMUM RATINGS (Tc = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	V _{DSS}	80	V
Gate-Source Voltage	V _{GSS}	±20	V
Drain Current	۱ _D	11	А
Reverse Drain Current	I _{DR}	11	А
Drain Power Dissipation	PD	250	W
Channel Temperature	T _{ch}	150	°C
Storage Temperature Range	T _{stg}	-55~150	°C



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ELECTRICAL CHARACTERISTICS (Tc = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Power	Po	V _{DD} = 40 V, lidle = 0.2 A × 2	90	110	_	W
Drain Efficiency	ηD	Pi = 10 W, f = 770 MHz *	_	50	_	%
Drain-Source Breakdown Voltage	V (BR) DSS	I _D = 5 mA, V _{GS} = 0	80	_	—	V
Drain Cut-off Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0	_	_	1.0	mA
Gate Threshold Voltage	V _{th}	I _D = 0.5 mA, V _{DS} = 10 V	0.5	_	3.0	V
Drain-Source ON Resistance	R _{DS (on)}	I _D = 2 A, V _{GS} = 10 V **	_	0.5	1.5	Ω
Drain-Source ON Voltage	V _{DS (on)}	I _D = 2 A, V _{GS} = 10 V **	_	1.0	3.0	V
Forward Transfer Admittance	Y _{fs}	I _D = 1.5 A, V _{DS} = 20 V **	0.9	1.3	_	S
Input Capacitance	C _{iss}	V _{DS} = 40 V, V _{GS} = 0, f = 1 MHz	_	80	_	pF
Output Capacitance	C _{oss}	V _{DS} = 40 V, V _{GS} = 0, f = 1 MHz	—	40	_	pF
Reverse Transfer Capacitance	C _{rss}	V _{DS} = 40 V, V _{GS} = 0, f = 1 MHz	_	1	_	pF

*: Push-Pull Operation **: Pulse Test

This transistor is the electrostatic sensitive device. Please handle with caution.

RF OUTPUT POWER TEST FIXTURE



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CAUTION

These are only typical curves and devices are not necessarily guaranteed at these curves.